

SWITCHMODETM

NPN Bipolar Power Transistor For Switching Power Supply Applications

The MJE18006 has an applications specific state-of-the-art die designed for use in 220 V line-operated SWITCHMODE Power supplies and electronic light ballasts. This high voltage/high speed transistor offers the following:

- Improved Efficiency Due to Low Base Drive Requirements:
 High and Flat DC Current Gain hFE
 Fast Switching
 No Coil Required in Base Circuit for Turn–Off (No Current Tail)
- Tight Parametric Distributions are Consistent Lot-to-Lot
- Standard TO-220

MAXIMUM RATINGS

Rating	Symbol	MJE18006	Unit
Collector–Emitter Sustaining Voltage	VCEO	450	Vdc
Collector–Emitter Breakdown Voltage	VCES	1000	Vdc
Emitter-Base Voltage	V _{EBO}	9.0	Vdc
Collector Current — Continuous — Peak(1)	I _C	6.0 15	Adc
Base Current — Continuous — Peak(1)	I _B I _{BM}	4.0 8.0	Adc
Total Device Dissipation (T _C = 25°C) Derate above 25°C	PD	100 0.8	Watts W/°C
Operating and Storage Temperature	T _J , T _{stg}	-65 to 150	°C

THERMAL CHARACTERISTICS

Rating	Symbol	MJE18006	Unit
Thermal Resistance — Junction to Case — Junction to Ambient	$R_{ heta JC}$	1.25 62.5	°C/W
Maximum Lead Temperature for Soldering Purposes: 1/8" from Case for 5 Seconds	TL	260	°C

ELECTRICAL CHARACTERISTICS (T_C = 25°C unless otherwise specified)

Characteristic	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS			_		
Collector–Emitter Sustaining Voltage (I _C = 100 mA, L = 25 mH)	VCEO(sus)	450	_	_	Vdc
Collector Cutoff Current (V _{CE} = Rated V _{CEO} , I _B = 0)	ICEO		_	100	μAdc
Collector Cutoff Current (V _{CE} = Rated V _{CES} , V _{EB} = 0)	ICES	_	_	100	μAdc
$(T_{C} = 125^{\circ}C)$		_	_	500	
$(V_{CE} = 800 \text{ V}, V_{EB} = 0)$ $(T_{C} = 125^{\circ}\text{C})$			_	100	
Emitter Cutoff Current (V _{EB} = 9.0 Vdc, I _C = 0)	I _{EBO}	1	_	100	μAdc

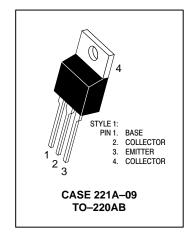
- (1) Pulse Test: Pulse Width = 5.0 ms, Duty Cycle $\leq 10\%$.
- (2) Proper strike and creepage distance must be provided.

Preferred devices are ON Semiconductor recommended choices for future use and best overall value.

MJE18006*

*ON Semiconductor Preferred Device

POWER TRANSISTOR 6.0 AMPERES 1000 VOLTS 100 WATTS



ELECTRICAL CHARACTERISTICS — **continued** ($T_C = 25$ °C unless otherwise specified)

Characteristic					Symbol	Min	Тур	Max	Unit
ON CHARACTERISTICS									
Base–Emitter Saturation Voltage ($I_C = 1.3$ Adc, $I_B = 0.13$ Adc) ($I_C = 3.0$ Adc, $I_B = 0.6$ Adc)			V _{BE(sat)}	_ _	0.83 0.94	1.2 1.3	Vdc		
Collector–Emitter Saturation Voltage (I _C = 1.3 Adc, I _B = 0.13 Adc) (T _C = 125°C) (I _C = 3.0 Adc, I _B = 0.6 Adc) (T _C = 125°C)				VCE(sat)	_ _ _ _	0.25 0.27 0.35 0.4	0.6 0.65 0.7 0.8	Vdc	
DC Current Gain (I _C = 0.5 Adc, V _{CE} = 5.0 Vdc) $ (T_{C} = 125^{\circ}C) $ $ (I_{C} = 3.0 \text{ Adc, V}_{CE} = 1.0 \text{ Vdc}) $ $ (T_{C} = 125^{\circ}C) $ $ (I_{C} = 1.3 \text{ Adc, V}_{CE} = 1.0 \text{ Vdc}) $ $ (T_{C} = 25 \text{ to } 125^{\circ}C) $ $ (I_{C} = 10 \text{ mAdc, V}_{CE} = 5.0 \text{ Vdc}) $			hFE	14 — 6.0 5.0 11 10	— 32 10 8.0 17 22	34 — — — — —	_		
DYNAMIC CHARACTERIS) [Ada] / 40	\/-l-	O MI I=)			4.4		NAL I-
Current Gain Bandwidth				.0 MHZ)	fT	_	14	400	MHz
Output Capacitance (VC			U IVIHZ)		C _{ob}		75	120	pF
Input Capacitance (VEB		/) 			C _{ib}		1000	1500	pF Volta
Dynamic Saturation Volta Determined 1.0 μs and	_	(I _C = 1.3 Adc I _{B1} = 130 mAdc	1.0 μs	$(T_C = 125^{\circ}C)$	VCE(dsat)		5.5 12		Volts
3.0 µs respectively after rising I _{B1} reaches 90% of		V _{CC} = 300 V)	3.0 µs	(T _C = 125°C)			3.0 7.0		
final I _{B1} (see Figure 18)		(IC = 3.0 Adc	1.0 μs	(T _C = 125°C)		_ _	9.5 14.5	_ _	
	I _{B1} VCC		3.0 µs	(T _C = 125°C)	•	_ _	2.0 7.5	_ _	
SWITCHING CHARACTE	RISTIC	S: Resistive Loa	d (D.C. ≤	10%, Pulse Wid	lth = 20 μs)		l		<u>I</u>
Turn-On Time		= 3.0 Adc, I _{B1} = 0 = 1.5 Adc, V _{CC} =		(T _C = 125°C)	ton	_	90 100	180 —	ns
Turn-Off Time				(T _C = 125°C)	toff		1.7 2.1	2.5 —	μs
Turn-On Time		= 1.3 Adc, I _{B1} = 0. = 0.65 Adc, V _{CC} =		(T _C = 125°C)	ton		200 130	300 —	ns
Turn-Off Time				(T _C = 125°C)	^t off		1.2 1.5	2.5 —	μs
SWITCHING CHARACTE	RISTIC	S: Inductive Loa	d (V _{clamp}	= 300 V, V _{CC} =	: 15 V, L = 200	μH)			
Fall Time	(IC =	= 1.5 Adc, I _{B1} = 0. I _{B2} = 0.65 Adc)		(T _C = 125°C)	t _{fi}		100 120	180 —	ns
Storage Time				(T _C = 125°C)	t _{Si}	_ _	1.5 1.9	2.5 —	μs
Crossover Time				(T _C = 125°C)	t _C	_ _	220 230	350 —	ns
Fall Time	(IC	= 3.0 Adc, I _{B1} = 0 I _{B2} = 1.5 Adc)	.6 Adc,	(T _C = 125°C)	t _{fi}	_ _	85 120	150 —	ns
Storage Time				(T _C = 125°C)	t _{Si}	_	2.15 2.75	3.2	μs
Crossover Time				(T _C = 125°C)	t _C	_	200 310	300 —	ns

TYPICAL STATIC CHARACTERISTICS

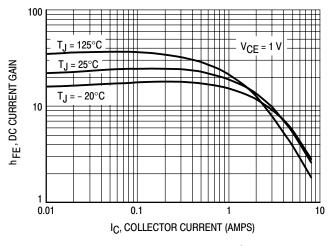


Figure 1. DC Current Gain @ 1 Volt

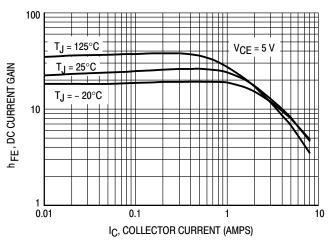


Figure 2. DC Current Gain @ 5 Volts

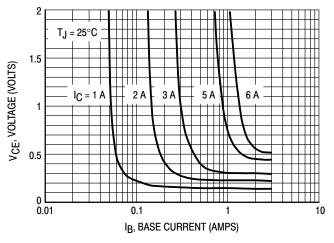


Figure 3. Collector Saturation Region

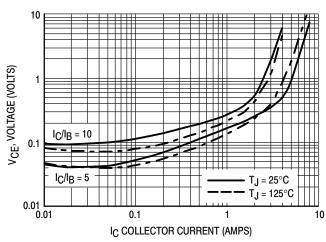


Figure 4. Collector-Emitter Saturation Voltage

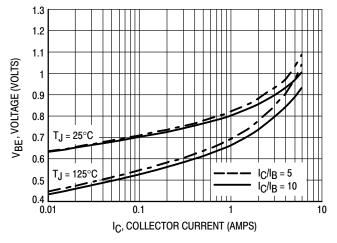


Figure 5. Base-Emitter Saturation Region

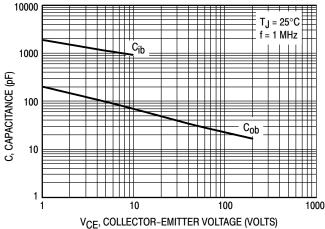


Figure 6. Capacitance

TYPICAL SWITCHING CHARACTERISTICS (IB2 = IC/2 for all switching)

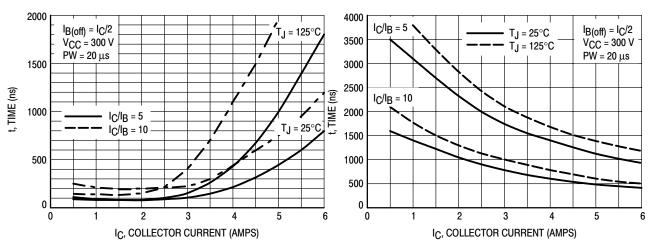


Figure 7. Resistive Switching, ton

Figure 8. Resistive Switching, toff

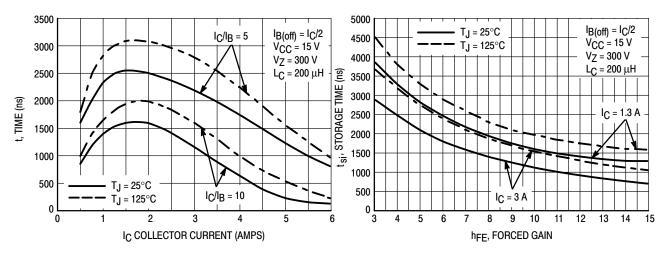


Figure 9. Inductive Storage Time, tsi

Figure 10. Inductive Storage Time, t_{Si}(h_{FE})

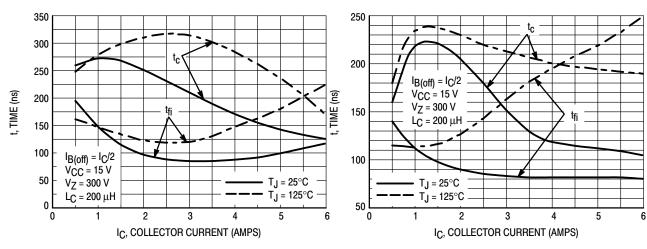
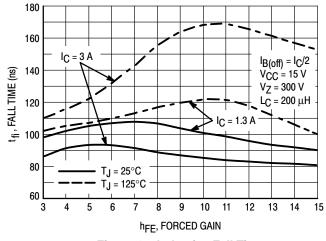


Figure 11. Inductive Switching, t_C and t_{fi} $I_C/I_B = 5$

Figure 12. Inductive Switching, t_C and t_{fi} $I_C/I_B = 10$

TYPICAL SWITCHING CHARACTERISTICS (IB2 = IC/2 for all switching)



350 I_B(off) = I_C/2 V_{CC} = 15 V V_Z = 300 V L_C = 200 μH IC = 3 A 300 T_C, CROSSOVER TIME (ns) 250 200 I_C = 1.3 A 150 100 T_J = 25°C Tj = 125°C 50 10 11 12 13 14 15 $h_{\mbox{\scriptsize FE}}, \mbox{\scriptsize FORCED GAIN}$

Figure 13. Inductive Fall Time

Figure 14. Inductive Crossover Time

GUARANTEED SAFE OPERATING AREA INFORMATION

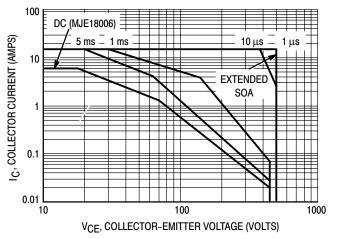


Figure 15. Forward Bias Safe Operating Area

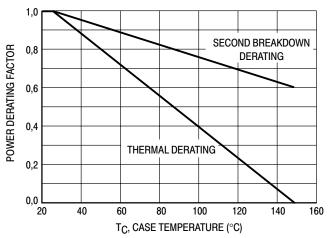


Figure 17. Forward Bias Power Derating

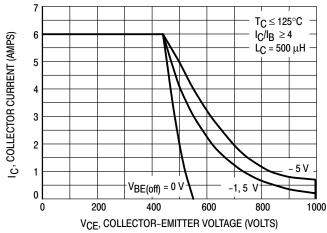
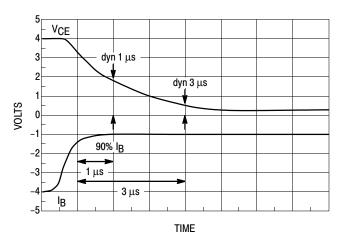


Figure 16. Reverse Bias Switching Safe Operating Area

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate IC - VCE limits of the transistor that must be observed for reliable operation; i.e., the transistor must not be subjected to greater dissipation than the curves indicate. The data of Figure 15 is based on TC. = 25° C; $T_{J(pk)}$ is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to 10% but must be derated when $T_C \ge 25$ °C. Second breakdown limitations do not derate the same as thermal limitations. Allowable current at the voltages shown in Figure 15 may be found at any case temperature by using the appropriate curve on Figure 17. $T_{J(pk)}$ may be calculated from the data in Figure 20. At any case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown. For inductive loads, high voltage and current must be sustained simultaneously during turn-off with the base-to-emitter junction reverse-biased. The safe level is specified as a reverse-biased safe operating area (Figure 16). This rating is verified under clamped conditions so that the device is never subjected to an avalanche mode.



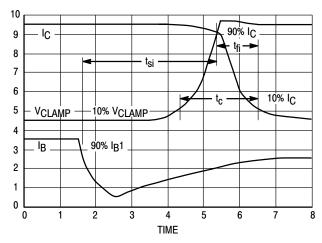


Figure 18. Dynamic Saturation Voltage Measurements

Figure 19. Inductive Switching Measurements

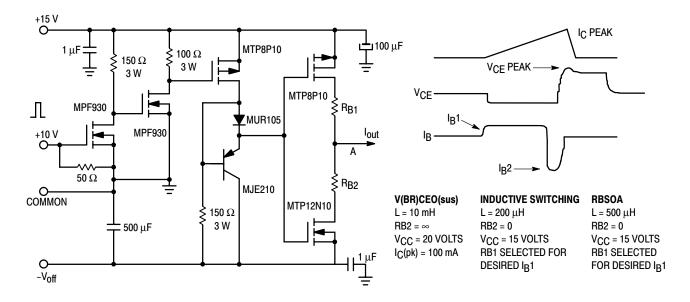


Table 1. Inductive Load Switching Drive Circuit

TYPICAL THERMAL RESPONSE

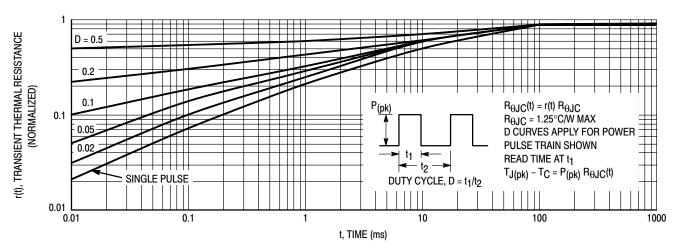
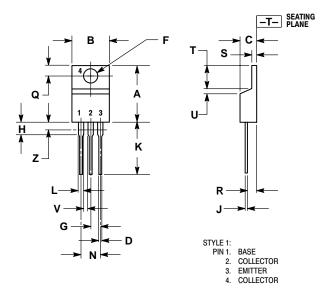


Figure 20. Typical Thermal Response ($Z_{\theta JC}(t)$) for MJE18006

PACKAGE DIMENSIONS

TO-220AB **CASE 221A-09 ISSUE AA**



NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.

- CONTROLLING DIMENSION: INCH.
 DIMENSION Z DEFINES A ZONE WHERE ALL BODY AND LEAD IRREGULARITIES ARE ALLOWED.

	INC	HES	MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.570	0.620	14.48	15.75	
В	0.380	0.405	9.66	10.28	
С	0.160	0.190	4.07	4.82	
D	0.025	0.035	0.64	0.88	
F	0.142	0.147	3.61	3.73	
G	0.095	0.105	2.42	2.66	
Н	0.110	0.155	2.80	3.93	
J	0.018	0.025	0.46	0.64	
K	0.500	0.562	12.70	14.27	
L	0.045	0.060	1.15	1.52	
N	0.190	0.210	4.83	5.33	
Q	0.100	0.120	2.54	3.04	
R	0.080	0.110	2.04	2.79	
S	0.045	0.055	1.15	1.39	
Т	0.235	0.255	5.97	6.47	
U	0.000	0.050	0.00	1.27	
٧	0.045		1.15		
Z		0.080		2.04	

SWITCHMODE is a trademark of Semiconductor Components Industries, LLC.

ON Semiconductor and war registered trademarks of Semiconductor Components Industries, LLC (SCILLC). SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer.

PUBLICATION ORDERING INFORMATION

Literature Fulfillment:

Literature Distribution Center for ON Semiconductor P.O. Box 5163, Denver, Colorado 80217 USA

Phone: 303-675-2175 or 800-344-3860 Toll Free USA/Canada Fax: 303-675-2176 or 800-344-3867 Toll Free USA/Canada

Email: ONlit@hibbertco.com

N. American Technical Support: 800-282-9855 Toll Free USA/Canada

JAPAN: ON Semiconductor, Japan Customer Focus Center 4-32-1 Nishi-Gotanda, Shinagawa-ku, Tokyo, Japan 141-0031

Phone: 81-3-5740-2700 Email: r14525@onsemi.com

ON Semiconductor Website: http://onsemi.com

For additional information, please contact your local

Sales Representative.